## MN101E34 Series

Туре	MN101EF34D
Internal ROM type	FLASH
ROM (byte)	64K+4K
RAM (byte)	4K
Package (Lead-free)	TQFP048-P-0707B
Minimum Instruction Execution Time	0.042 μs (at 2.2 V to 5.5 V, 24 MHz) 62.5 μs (at 2.2 V to 5.5 V, 32 kHz)

#### ■ Interrupts

RESET. Watchdog. External 0 to 4. External 5 (key interrupt dedicated). External 6. Timer 0 to 4. Timer 6. Timer 7 (2 systems). Timer 8 (2 systems). Timer 9 (2 systems). Time base. Serial 1 (2 systems). Serial 2 (2 systems). Serial 4 (2 systems). A/D conversion finish

#### ■ Timer Counter

0.1.			-
8-bit	timer	X	6

Timer 0	Square-wave output.	PWM output.	Event count.	Simple pulse width	n measurement.	Square-wave/PWM output t	0
1	arge current terminal	P03 (TM0IC	B) possible				

Timer 1 ......Square-wave output. Event count

Timer 2Square-wave o	tput. PWM output. Event count. Simple pulse width measurement. Square-wave/PWM output to
large current te	minal P03 (TM2IOB) possible

Timer 3 ......Square-wave output. Event count

Timer 4 ......Square-wave output. PWM output. Event count. Simple pulse width measurement. Square-wave/PWM output to large current terminal P02 (TM4IOC) possible

Timer 6 .....8-bit freerun timer

Timer 0, 1 can be cascade-connected

Timer 2, 3 can be cascade-connected

Timer 0, 1, 2 can be cascade-connected

Timer 0, 1, 2, 3 can be cascade-connected

16-bit timer  $\times$  3

Timer 7Square-wa	ve output. PWM output (cycle/duty	continuous variable). Ever	nt count. Pulse width measur	ement. Input		
capture. Square-wave/PWM output to large current terminal P00 (TM7IOB) possible						

Timer 8 ......Square-wave output. PWM output (cycle/duty continuous variable). Event count. Pulse width measurement. Input capture. Square-wave/PWM output to large current terminal P01 (TM8IOB) possible

Timer 9 ......Square-wave output. PWM output (cycle/duty continuous variable). Event count. Pulse width measurement. Input capture

Time base timer: One-minute count setting

Watchdog timer  $\times$  1

#### ■ Serial interface

Synchronous type/UART (full-duplex)  $\times$  2: Serial 1, 2

Synchronous type/Multi-master I<sup>2</sup>C × 1: Serial 4

Serial 4.....7-bit/10-bit address setting. General call

## ■ I/O Pins

I/O 39: Common use. Specified pull-up resistor available. Input/output selectable (bit unit)

#### ■ A/D converter

10-bit  $\times$  8 channels (with S/H)

#### ■ Extended Calculation

16-bit × 16-bit multiplication. 32-bit / 16-bit division

#### ■ Special Ports

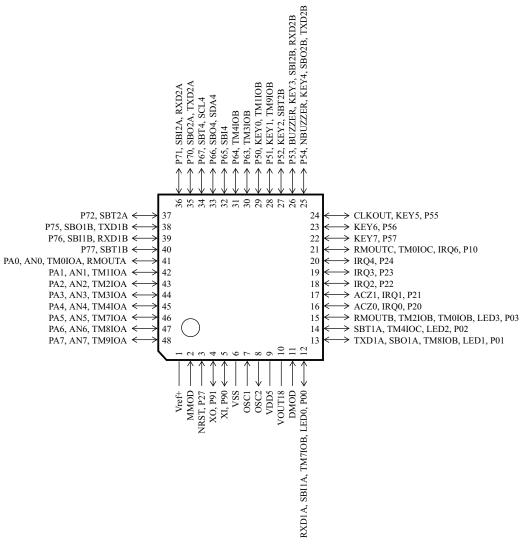
Buzzer output. Remote control carrier output. High-current drive port. Clock output

### ■ ROM Correction

Correcting address designation: Up to 7 addresses possible

Panasonic MAD00060FEM

■ Pin Assignment TQFP048-P-0707B



MAD00060FEM Panasonic

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